Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/670,587	BIAN, JINRU
Examiner	Art Unit
Gregory E. Webb	1751

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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parted sub search	1			
252 79.1,79.2,79.4				
438/192,693				
510/175	di			
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